MOSFET – Power, Single N-Channel 40 V, 4.2 mΩ, 83 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Cur-	Steady State	T _C = 25°C	I _D	82	Α
rent R _{θJC} (Notes 1 & 3)		T _C = 100°C		58	
Power Dissipation R _{θJC}		T _C = 25°C	P_{D}	56	W
(Note 1)		$T_C = 100^{\circ}C$		28	
Continuous Drain	Steady State	T _A = 25°C	I _D	19	Α
Current R _{0JA} (Notes 1, 2 & 3)		T _A = 100°C		14	
Power Dissipation R _{θJA}		T _A = 25°C	P _D	3.1	W
(Notes 1 & 2)		T _A = 100°C		1.5	
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	446	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			I _S	46	Α
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, I _{L(pk)} = 8.3 A)			E _{AS}	205	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48.4	1

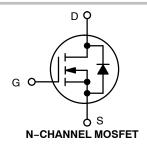
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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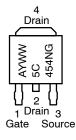
V _{(BR)DSS}	R _{DS(on)}	I _D	
40 V	4.2 m Ω @ 10 V	83 A	





DPAK CASE 369C STYLE 2

MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location

Y = Year WW = Work Week 5C454N = Device Code G = Pb-Free Package

ORDERING INFORMATION

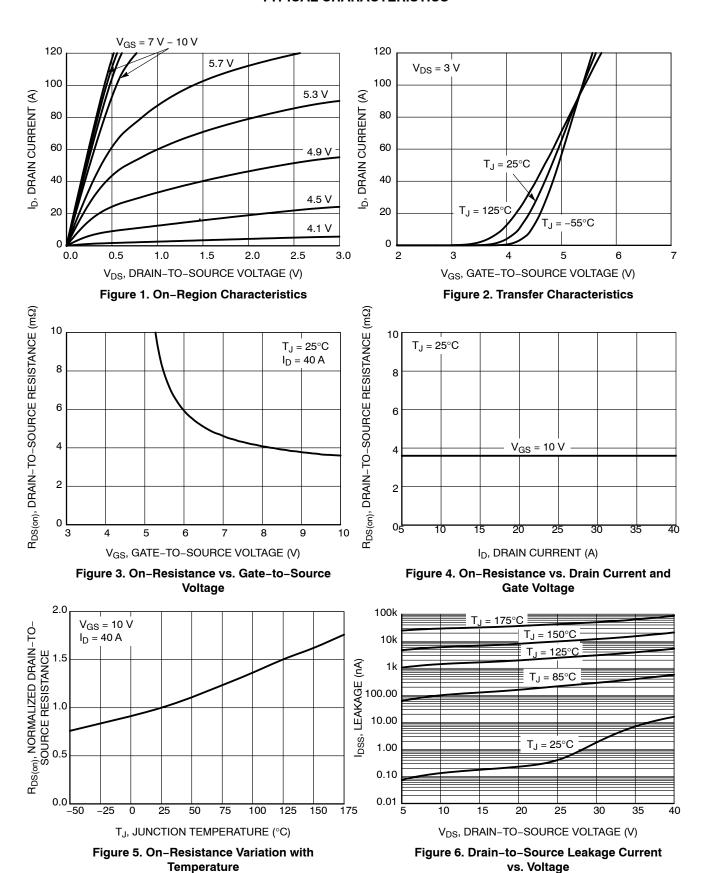
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	V _{GS} = 0 V,	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			10	μΑ
		T _J = 125°C			250	1	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 70 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.9		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	₀ = 40 A		3.6	4.2	mΩ
Forward Transconductance	9FS	$V_{DS} = 3 \text{ V}, I_{D}$	= 40 A		80		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						
Input Capacitance	C _{iss}				1900		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$	1.0 MHz, 5 V		950		
Reverse Transfer Capacitance	C _{rss}	*DS = 25	,		48		
Total Gate Charge	Q _{G(TOT)}				32		nC
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 40 A			5.7		1
Gate-to-Source Charge	Q _{GS}				9.5		1
Gate-to-Drain Charge	Q_{GD}				6.6		1
Plateau Voltage	V _{GP}				4.8		V
SWITCHING CHARACTERISTICS (Note 5)					•		•
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	Vos = 10 V. Vp	oc = 32 V.		47		
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 40 A, R_{G} = 2.5 Ω			24		1
Fall Time	t _f				8		1
DRAIN-SOURCE DIODE CHARACTERISTIC	S						<u> </u>
Forward Diode Voltage	V _{SD}	Voc - 0 V	T _J = 25°C		0.9	1.2	V
-		$V_{GS} = 0 V$, $I_S = 40 A$	T _J = 125°C		0.8		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = 40 A			45		ns
Charge Time	ta				24		1
Discharge Time	tb				21		1
Reverse Recovery Charge	Q _{RR}				20		nC
· •					<u> </u>	I	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

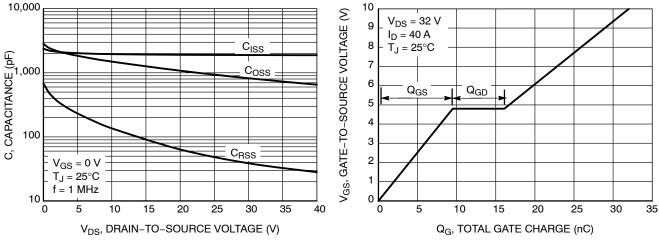


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

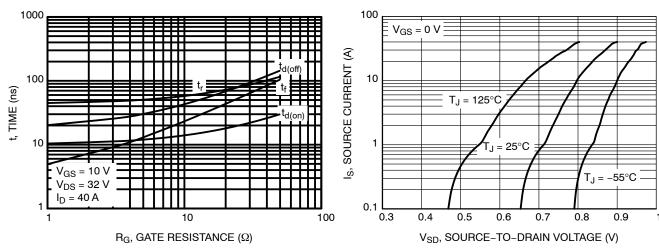


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

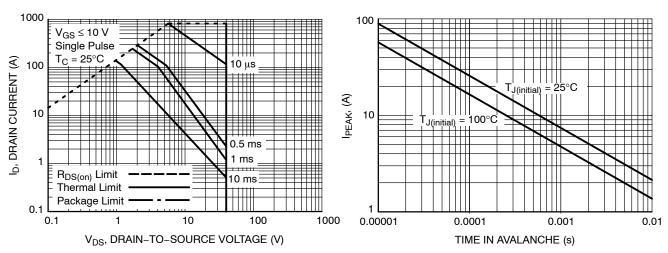


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

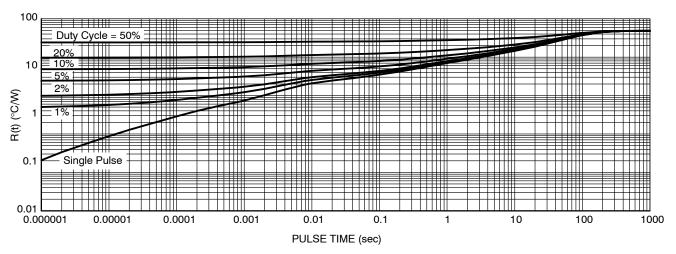


Figure 13. Thermal Response

ORDERING INFORMATION

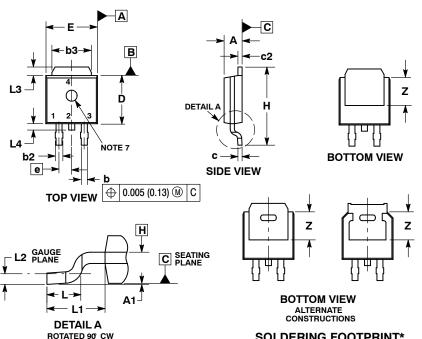
Order Number	Package	Shipping [†]
NVD5C454NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C **ISSUE F**



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

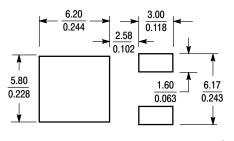
	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE 2. DRAIN

- 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



mm SCALE 3:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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